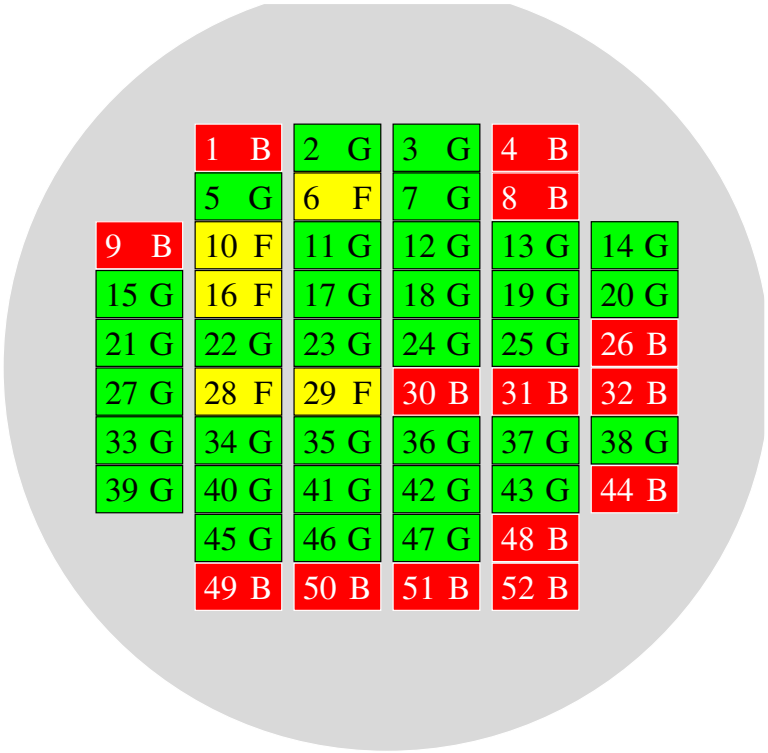
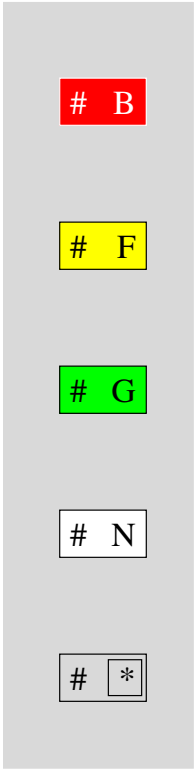
Die quality map for wafer 33 s/n: 21316-06-16 (not backplated)

Date: 11/02/98




Bad die

Fair die

Good die

No info

Manually tagged